

<b>Notice of References Cited</b>	Application/Control No. 09/892,490	Applicant(s)/Patent Under Reexamination PARKHILL ET AL.	
	Examiner Ponnoreay Pich	Art Unit 2135	Page 1 of 1

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*	B	US-5,796,841	08-1998	Cordery et al.	380/55
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"IEEE 100 The Authoritative Dictionary of IEEE Standards Terms, Seventh Edition", copyright 2000, page 1031.
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